Machine Protection Needs in ERLs

ERL'09 – June 8, 2009





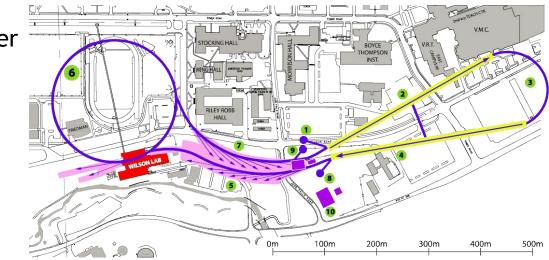


- High average beam power:
 100 mA · 5 GeV/e = 500 MW
- In case of strong losses:

Breakdown of energy recovery → maximum loss power determined by capacity of RF system

• In case of small losses:

Tiny fraction of the beam still carries huge average power



Hazards

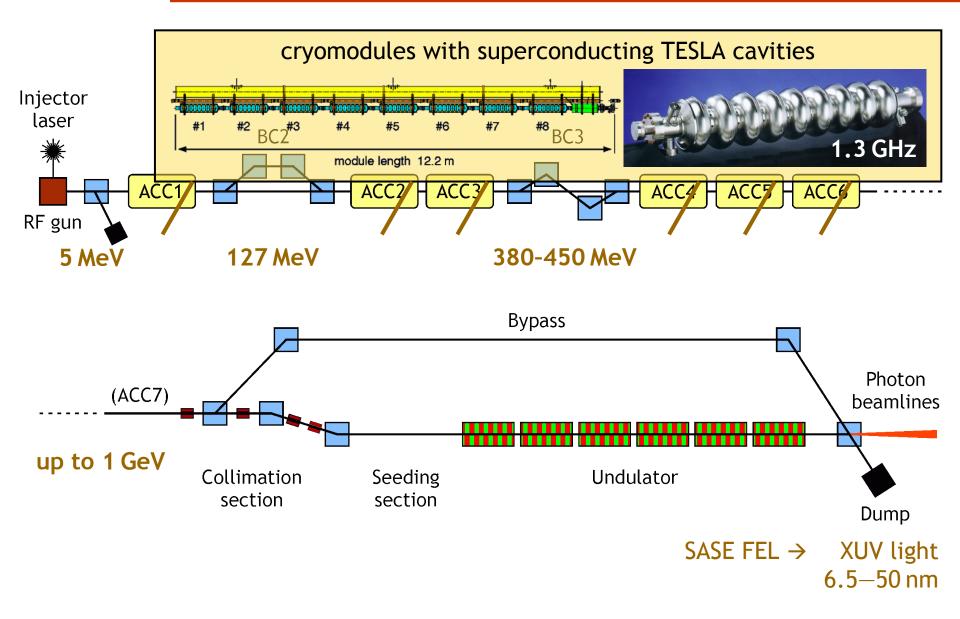
For an ERL with **P** = 100 MW:

Local loss power (W)	Effects	
10 ⁻¹¹	Demagnetization of permanent magnets	
1 - 10	Excessive cryogenic load, quenches	
1 — 100	Radiation damage to electronics, optical components, &c.	PLAINO
1 - 100	Radioactivation of components	
10 - 100	Mechanical failure of flange connections	
100 - 1000 10-5	Other thermal effects, mechanical damage	

Hazards

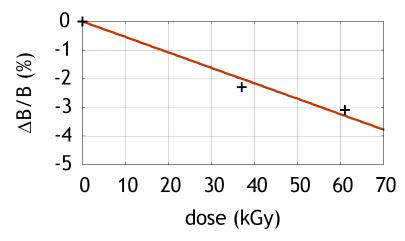
Local loss power (W)	Effects	
0.001 – 0.1	Demagnetization of permanent magnets	
1 — 10	Excessive cryogenic load, quenches	
1 — 100	Radiation damage to electronics, optical components, &c.	PALIMOLACTIMANOCTIM
1 — 100	Radioactivation of components	
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FLASH – Not an ERL...



• Relative demagnetization: 5·10⁻⁷/Gy

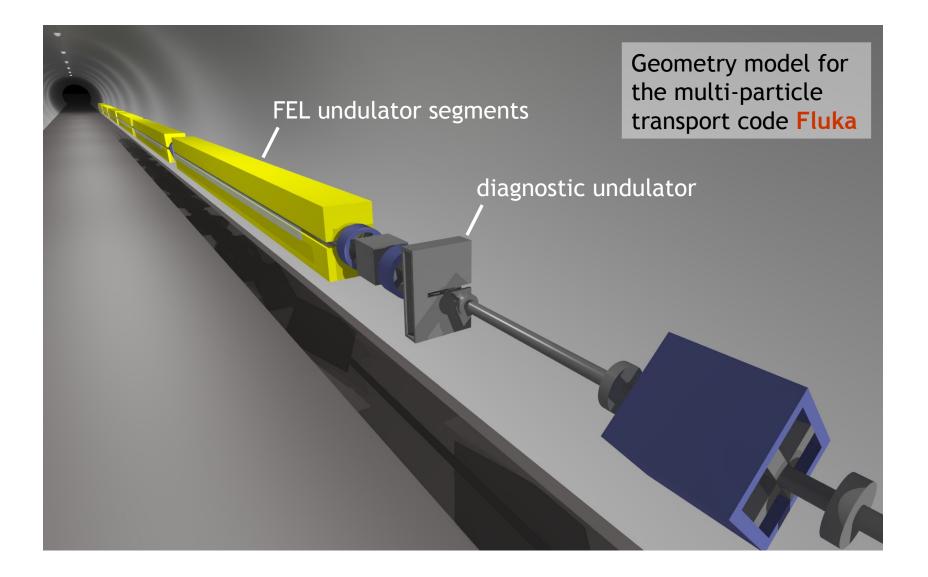
	Dose	
2004-08-13	(kGy) 0	(%)
2006-03-21	37	-2.3
2007-09-29	61	-3.1



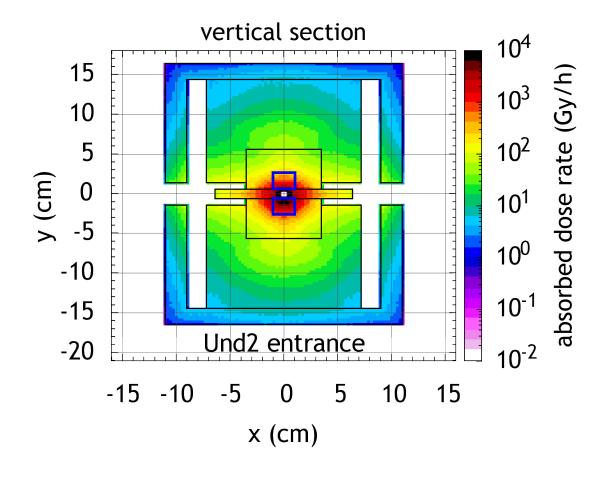
Skupin, Li, Pflüger, Faatz: Undulator demagnetization due to radiation losses at FLASH, *Proc. EPAC 2008*, pp. 2308-2310

Simulations indicate **10% FEL power loss** for **0.5% (periodic) field loss** For 10 years undulator lifetime: **5 Gy/d** dose budget

Undulator Beamline Model



Beam Loss in the Undulator

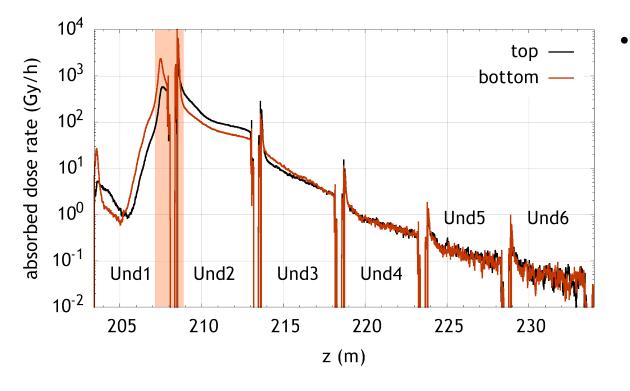


- Loss of a bunch at the exit of undulator 1
- Bunch strikes the bottom of the vacuum chamber

Parameters:

- 1 GeV
- 1 nC/bunch
- 1 bunch/macropulse
- 10 Hz

Beam Loss in the Undulator



Dose rate around 1 kGy/hin an extended range (1 nC/bunch, 10 Hz, 1 GeV) $\rightarrow 10 \text{ W})$

To stay within 5 Gy/d, local beam loss has to be limited to **2 mW**.

For a 100 MW beam:

2.10⁻¹¹ (relative)

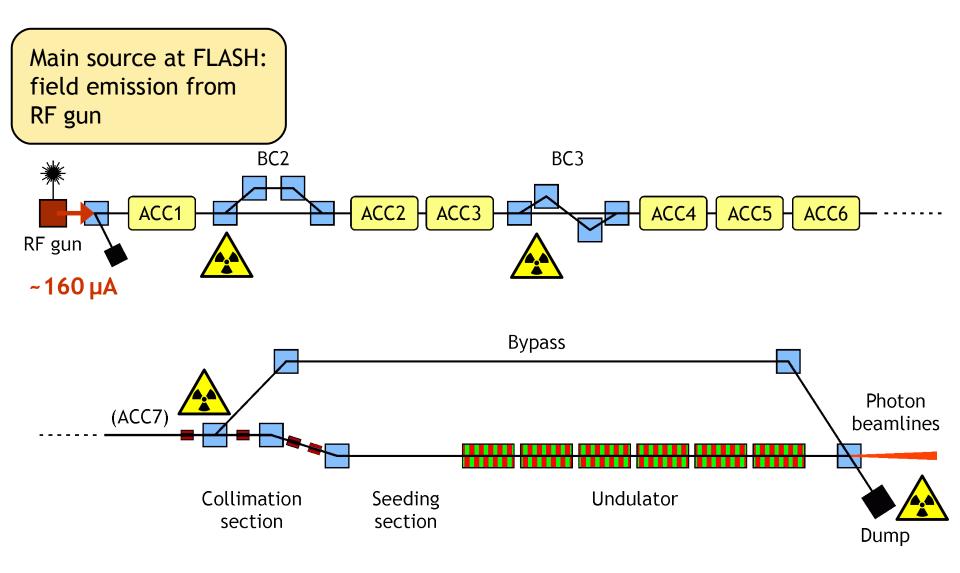
For CW 1.3 GHz beam:

<10 MeV/bunch

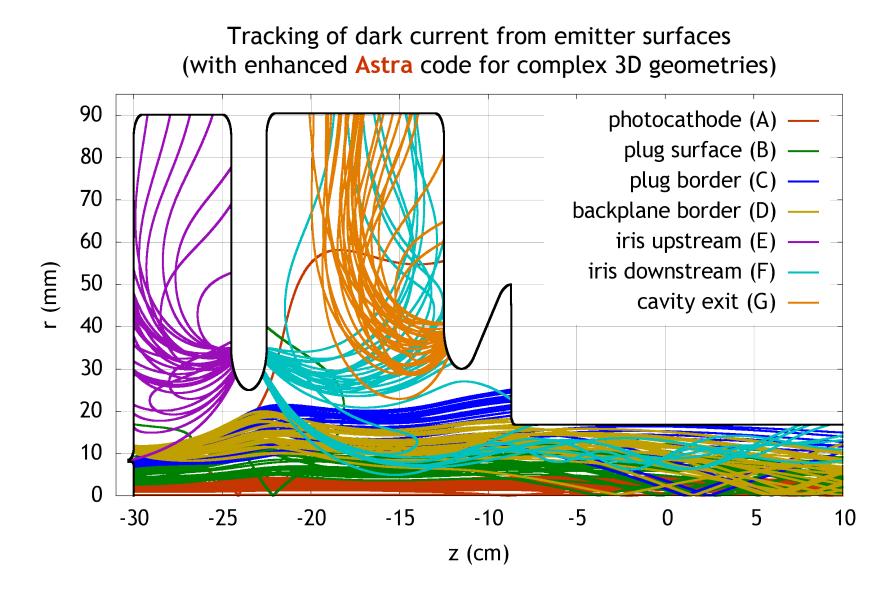
Hazards

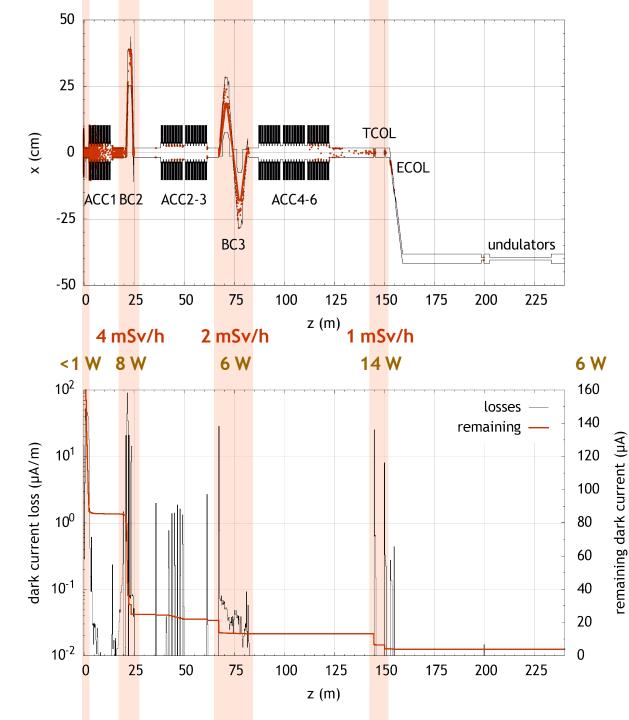
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Activation of Components at FLASH



Dark Current Transport in the RF Gun Cavity





Overview

Location of major dark current losses:

- behind rf gun
- bunch compressor 2
- bunch compressor 3
- transverse collimators

contact dose equivalent rate dark current power deposition

For 100 MW ERL: relative beam loss of **10⁻⁷** can cause significant activation problems

Machine Protection Needs

for high power ERLs

Passive Protection Needs

Very good understanding and control of beam dynamics:

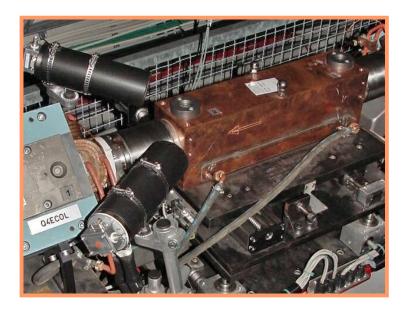
- matching
- halo formation
- space charge, CSR, Touschek scattering, gas scattering, ion trapping, BBU
- dark current sources & transport

Very good collimation & shielding:

- at energies as low as possible
- after halo sources
- special attention: cryo sections, insertion devices (esp. long ID sections)

What may help:

- large apertures
- exchangeable insertion devices



Machine Protection System Needs

Preventive measures

- Check magnet currents, RF systems, water flow, &c.
- Define valid beam paths (operation modes, machine modes)
- Define power limits (beam modes)

Fast beam interlock

- As fast as possible: microseconds (cable delays)
- Actuators:
 - injector laser
 - RF power
 - dump kickers (for long machines)
- Inputs:
 - Systems for beam loss detection
 - BPMs
 - Quench detection for SC cavities

Beam Loss Monitoring

Differential current monitoring

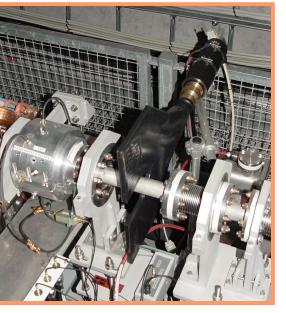
• DCCT setup proposed at BNL aims at 5.10⁻⁴ resolution

P. Cameron, Differential Current Measurement in the BNL Energy Recovery Linac Test Facility, Nucl. Instr. and Meth. A 557 (2006), pp. 331-333

Beam loss monitors

- wide range of photomultiplier-based designs
- discrete ionization chambers
- long ionization chambers (gas-filled coax cables)
- PIN diodes
- secondary electron monitors

well suited for ID protection



Thanks for your attention.

